

Search Notes**Application/Control No.**

10/763,981

Examiner

Surekha Vathyam

Applicant(s)/Patent under Reexamination

VIGH, GYULA

Art Unit

1753

SEARCHED

Class	Subclass	Date	Examiner
204	548, 644	8/29/2007	SV
204	450-470	8/29/2007	SV
204	600-621	8/29/2007	SV
updated		7-10-2008	KKO
updated		1/16/2009	KKO

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
see attached EAST search history	8/29/2007	SV
Inventor name search on EAST and Google Scholar	8/29/2007	SV
Searched Google Scholar keywords IEF auxiliary pH bias	8/29/2007	SV
Consulted Alex Noguerola for search	8/29/2007	SV